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| U.S. Department of Commerce, Patent and Trademark Office | | | | Atty Docket No. | | Serial No. | | |
| | | | | M-10699 US | | 09/671,715 | | |
| INFORMATION DISCLOSURE STATEMENT BY APPLICANT | | | | Applicant(s) | | | | |
| (Use several sheets if necessary) | | | | ANATOLY FABRIKANT ET AL. | | | | |
| | | | | Filing Date | | Group | | |
| | | | | September 27, 2000 | | 2877 | | |
| U.S. Patent Documents | | | | | | | | |
| *Examiner Initial | | Document Number | Date | Name | Class | Subclass | Filing Date If Appropriate | |
| | AA | | | | | | | |
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| | | | | | | | Translation | |
| | | Document | Date | Country | Class | Subclass | Yes | No |
| 38 | AL | WO99/45340 | 9/10/99 | International | | | X | |
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| OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.) | | | | | | | | |
| 38 | AQ | "Multilayer modal method for diffraction gratings of arbitrary profile, depth, and permittivity," L. Li, <i>J. Opt. Soc. Am. A.</i> , Vol. 10, No. 12, December 1993, pp. 2581-2591 | | | | | | |
| 38 | AR | "Rigorous coupled-wave analysis of planar-grating diffraction," M.G. Moharam et al., <i>J. Opt. Soc. Am.</i> , Vol. 71, No. 7, July 1981, pp. 811-818 | | | | | | |
| 38 | AS | "Coupled-Wave Analysis of Two-Dimensional Dielectric Gratings," M.G. Moharam, <i>SPIE, Vol. 888, Holographic Optics: Design and Applications</i> , 1988, pp. 8-11 | | | | | | |
| Examiner | | Date Considered 12/4/03 | | | | | | |
| *EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication to applicant. | | | | | | | | |